Random bad cell map for wafer 210 s/n: 21316-15-12

Date: 10/20/99

		0	0	3	0	0		
		49		1	2	2		
	1	7	3	0	0	1	0	
	2	0	0	0	2	1		
0	0	0	30	1	0	8		
1		3	0		0	1	35	
1	2	0	0	1	46	0	0	3
60	1	1	0		0	412	0	0
0		0	0	0	1	0	0	
0		0	10	0	0	1	1	
0	0	0	0	0	1		0	0
1	0	1	0	0	3		0	
0	9	1	1	0		0	0	
1		0	0	1	0	0	0	
		0	2	0	0	0	0	
	1	0	0	0		0	1	
		0	0	0	2	32		
		0	0	0	1	14		

#	Number of bad cells in random locations
	No info